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### What is "[Embedded - Microcontrollers](#)"?

"[Embedded - Microcontrollers](#)" refer to small, integrated circuits designed to perform specific tasks within larger systems. These microcontrollers are essentially compact computers on a single chip, containing a processor core, memory, and programmable input/output peripherals. They are called "embedded" because they are embedded within electronic devices to control various functions, rather than serving as standalone computers. Microcontrollers are crucial in modern electronics, providing the intelligence and control needed for a wide range of applications.

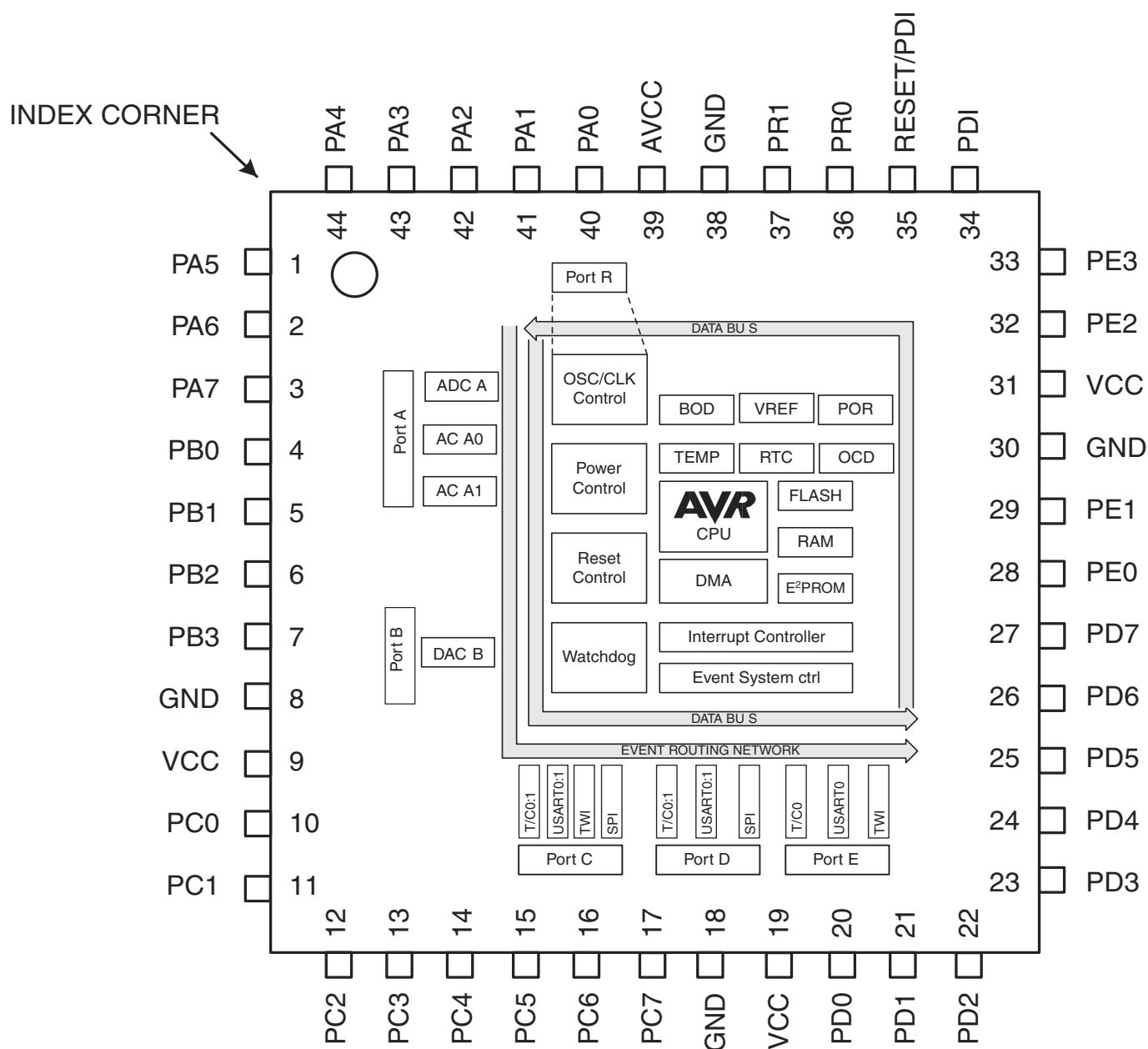
### Applications of "[Embedded - Microcontrollers](#)"

#### Details

Product Status	Active
Core Processor	AVR
Core Size	8/16-Bit
Speed	32MHz
Connectivity	I <sup>2</sup> C, IrDA, SPI, UART/USART
Peripherals	Brown-out Detect/Reset, DMA, POR, PWM, WDT
Number of I/O	34
Program Memory Size	32KB (16K x 16)
Program Memory Type	FLASH
EEPROM Size	1K x 8
RAM Size	4K x 8
Voltage - Supply (Vcc/Vdd)	1.6V ~ 3.6V
Data Converters	A/D 12x12b; D/A 2x12b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 85°C (TA)
Mounting Type	Surface Mount
Package / Case	44-VFQFN Exposed Pad
Supplier Device Package	44-VQFN (7x7)
Purchase URL	<a href="https://www.e-xfl.com/product-detail/microchip-technology/atxmega32a4-mh">https://www.e-xfl.com/product-detail/microchip-technology/atxmega32a4-mh</a>

## 2. Pinout/Block Diagram

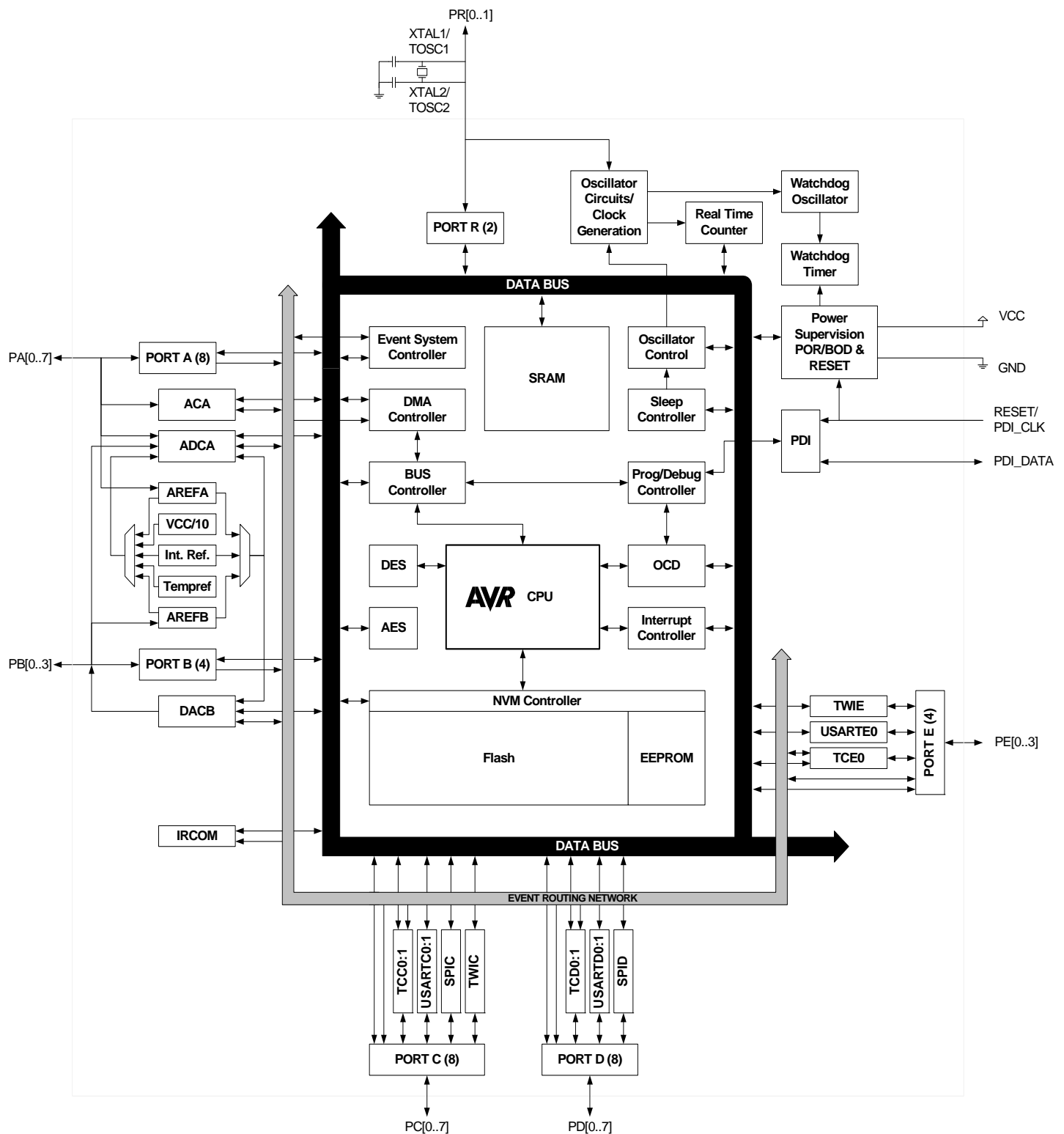
Figure 2-1. Block Diagram and TQFP/QFN pinout



- Notes:
1. For full details on pinout and pin functions refer to "Pinout and Pin Functions" on page 49.
  2. The large center pad underneath the QFN/MLF package should be soldered to ground on the board to ensure good mechanical stability.

## 3.1 Block Diagram

Figure 3-1. XMEGA A4 Block Diagram



## **4. Resources**

A comprehensive set of development tools, application notes and datasheets are available for download on <http://www.atmel.com/avr>.

### **4.1 Recommended reading**

- Atmel AVR XMEGA A Manual
- XMEGA A Application Notes

This device data sheet only contains part specific information and a short description of each peripheral and module. The XMEGA A Manual describes the modules and peripherals in depth. The XMEGA A application notes contain example code and show applied use of the modules and peripherals.

The XMEGA A Manual and Application Notes are available from <http://www.atmel.com/avr>.

## **5. Disclaimer**

For devices that are not available yet, typical values contained in this datasheet are based on simulations and characterization of other AVR XMEGA microcontrollers manufactured on the same process technology. Min. and Max values will be available after the device is characterized.

## 12. System Control and Reset

### 12.1 Features

- Multiple reset sources for safe operation and device reset
  - Power-On Reset
  - External Reset
  - Watchdog Reset
    - The Watchdog Timer runs from separate, dedicated oscillator
  - Brown-Out Reset
    - Accurate, programmable Brown-Out levels
  - PDI reset
  - Software reset
- Asynchronous reset
  - No running clock in the device is required for reset
- Reset status register

### 12.2 Resetting the AVR

During reset, all I/O registers are set to their initial values. The SRAM content is not reset. Application execution starts from the Reset Vector. The instruction placed at the Reset Vector should be an Absolute Jump (JMP) instruction to the reset handling routine. By default the Reset Vector address is the lowest Flash program memory address, '0', but it is possible to move the Reset Vector to the first address in the Boot Section.

The I/O ports of the AVR are immediately tri-stated when a reset source goes active.

The reset functionality is asynchronous, so no running clock is required to reset the device.

After the device is reset, the reset source can be determined by the application by reading the Reset Status Register.

### 12.3 Reset Sources

#### 12.3.1 Power-On Reset

The MCU is reset when the supply voltage VCC is below the Power-on Reset threshold voltage.

#### 12.3.2 External Reset

The MCU is reset when a low level is present on the RESET pin.

#### 12.3.3 Watchdog Reset

The MCU is reset when the Watchdog Timer period expires and the Watchdog Reset is enabled. The Watchdog Timer runs from a dedicated oscillator independent of the System Clock. For more details see "WDT - Watchdog Timer" on page 24.

#### 12.3.4 Brown-Out Reset

The MCU is reset when the supply voltage VCC is below the Brown-Out Reset threshold voltage and the Brown-out Detector is enabled. The Brown-out threshold voltage is programmable.

### 12.3.5 PDI reset

The MCU can be reset through the Program and Debug Interface (PDI).

### 12.3.6 Software reset

The MCU can be reset by the CPU writing to a special I/O register through a timed sequence.

## 13. WDT - Watchdog Timer

### 13.1 Features

- 11 selectable timeout periods, from 8 ms to 8s.
- Two operation modes
  - Standard mode
  - Window mode
- Runs from the 1 kHz output of the 32 kHz Ultra Low Power oscillator
- Configuration lock to prevent unwanted changes

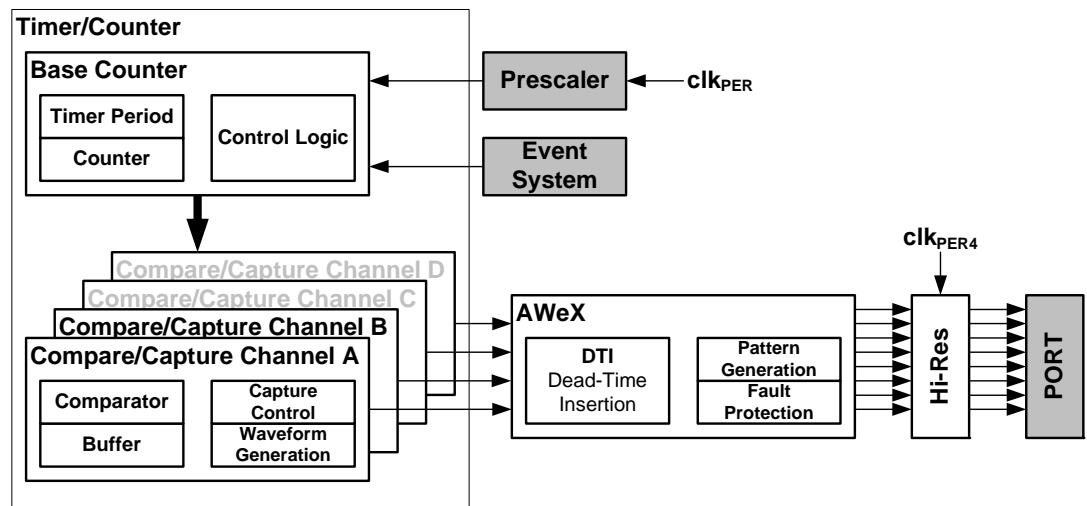
### 13.2 Overview

The XMEGA A4 has a Watchdog Timer (WDT). The WDT will run continuously when turned on and if the Watchdog Timer is not reset within a software configurable time-out period, the microcontroller will be reset. The Watchdog Reset (WDR) instruction must be run by software to reset the WDT, and prevent microcontroller reset.

The WDT has a Window mode. In this mode the WDR instruction must be run within a specified period called a window. Application software can set the minimum and maximum limits for this window. If the WDR instruction is not executed inside the window limits, the microcontroller will be reset.

A protection mechanism using a timed write sequence is implemented in order to prevent unwanted enabling, disabling or change of WDT settings.

For maximum safety, the WDT also has an Always-on mode. This mode is enabled by programming a fuse. In Always-on mode, application software can not disable the WDT.

**Figure 16-1.** Overview of a Timer/Counter and closely related peripherals

The Hi-Resolution Extension can be enabled to increase the waveform generation resolution by 2 bits (4x). This is available for all Timer/Counters. See "Hi-Res - High Resolution Extension" on page 34 for more details.

The Advanced Waveform Extension can be enabled to provide extra and more advanced feature for the Timer/Counter. This is only available for Timer/Counter 0. See "AWEX - Advanced Waveform Extension" on page 33 for more details.

## **21. SPI - Serial Peripheral Interface**

### **21.1 Features**

- **Two Identical SPI peripherals**
- **Full-duplex, Three-wire Synchronous Data Transfer**
- **Master or Slave Operation**
- **LSB First or MSB First Data Transfer**
- **Seven Programmable Bit Rates**
- **End of Transmission Interrupt Flag**
- **Write Collision Flag Protection**
- **Wake-up from Idle Mode**
- **Double Speed (CK/2) Master SPI Mode**

### **21.2 Overview**

The Serial Peripheral Interface (SPI) allows high-speed full-duplex, synchronous data transfer between different devices. Devices can communicate using a master-slave scheme, and data is transferred both to and from the devices simultaneously.

PORTC and PORTD each has one SPI. Notation of these peripherals are SPIC and SPID, respectively.



## **22. USART**

### **22.1 Features**

- **Five Identical USART peripherals**
- **Full Duplex Operation (Independent Serial Receive and Transmit Registers)**
- **Asynchronous or Synchronous Operation**
- **Master or Slave Clocked Synchronous Operation**
- **High-resolution Arithmetic Baud Rate Generator**
- **Supports Serial Frames with 5, 6, 7, 8, or 9 Data Bits and 1 or 2 Stop Bits**
- **Odd or Even Parity Generation and Parity Check Supported by Hardware**
- **Data OverRun Detection**
- **Framing Error Detection**
- **Noise Filtering Includes False Start Bit Detection and Digital Low Pass Filter**
- **Three Separate Interrupts on TX Complete, TX Data Register Empty and RX Complete**
- **Multi-processor Communication Mode**
- **Double Speed Asynchronous Communication Mode**
- **Master SPI mode for SPI communication**
- **IrDA support through the IRCOM module**

### **22.2 Overview**

The Universal Synchronous and Asynchronous serial Receiver and Transmitter (USART) is a highly flexible serial communication module. The USART supports full duplex communication, and both asynchronous and clocked synchronous operation. The USART can also be set in Master SPI mode to be used for SPI communication.

Communication is frame based, and the frame format can be customized to support a wide range of standards. The USART is buffered in both direction, enabling continued data transmission without any delay between frames. There are separate interrupt vectors for receive and transmit complete, enabling fully interrupt driven communication. Frame error and buffer overflow are detected in hardware and indicated with separate status flags. Even or odd parity generation and parity check can also be enabled.

One USART can use the IRCOM module to support IrDA 1.4 physical compliant pulse modulation and demodulation for baud rates up to 115.2 kbps.

PORTC and PORTD each has two USARTs. PORTE has one USART. Notation of these peripherals are USARTC0, USARTC1, USARTD0, USARTD1 and USARTE0, respectively.

## **23. IRCOM - IR Communication Module**

### **23.1 Features**

- Pulse modulation/demodulation for infrared communication
- Compatible to IrDA 1.4 physical for baud rates up to 115.2 kbps
- Selectable pulse modulation scheme
  - 3/16 of baud rate period
  - Fixed pulse period, 8-bit programmable
  - Pulse modulation disabled
- Built in filtering
- Can be connected to and used by one USART at a time

### **23.2 Overview**

XMEGA contains an Infrared Communication Module (IRCOM) for IrDA communication with baud rates up to 115.2 kbps. This supports three modulation schemes: 3/16 of baud rate period, fixed programmable pulse time based on the Peripheral Clock speed, or pulse modulation disabled. There is one IRCOM available which can be connected to any USART to enable infrared pulse coding/decoding for that USART.

## **28. OCD - On-chip Debug**

### **28.1 Features**

- **Complete Program Flow Control**
  - Go, Stop, Reset, Step into, Step over, Step out, Run-to-Cursor
- **Debugging on C and high-level language source code level**
- **Debugging on Assembler and disassembler level**
- **1 dedicated program address or source level breakpoint for AVR Studio / debugger**
- **4 Hardware Breakpoints**
- **Unlimited Number of User Program Breakpoints**
- **Unlimited Number of User Data Breakpoints, with break on:**
  - Data location read, write or both read and write
  - Data location content equal or not equal to a value
  - Data location content is greater or less than a value
  - Data location content is within or outside a range
  - Bits of a data location are equal or not equal to a value
- **Non-Intrusive Operation**
  - No hardware or software resources in the device are used
- **High Speed Operation**
  - No limitation on debug/programming clock frequency versus system clock frequency

### **28.2 Overview**

The XMEGA A4 has a powerful On-Chip Debug (OCD) system that - in combination with Atmel's development tools - provides all the necessary functions to debug an application. It has support for program and data breakpoints, and can debug an application from C and high level language source code level, as well as assembler and disassembler level. It has full Non-Intrusive Operation and no hardware or software resources in the device are used. The ODC system is accessed through an external debugging tool which connects to the PDI physical interface. Refer to "Program and Debug Interfaces" on page 48.

Mnemonics	Operands	Description	Operation	Flags	#Clocks
CALL	k	call Subroutine	PC ← k	None	3 / 4 <sup>(1)</sup>
RET		Subroutine Return	PC ← STACK	None	4 / 5 <sup>(1)</sup>
RETI		Interrupt Return	PC ← STACK	I	4 / 5 <sup>(1)</sup>
CPSE	Rd,Rr	Compare, Skip if Equal	if (Rd = Rr) PC ← PC + 2 or 3	None	1 / 2 / 3
CP	Rd,Rr	Compare	Rd - Rr	Z,C,N,V,S,H	1
CPC	Rd,Rr	Compare with Carry	Rd - Rr - C	Z,C,N,V,S,H	1
CPI	Rd,K	Compare with Immediate	Rd - K	Z,C,N,V,S,H	1
SBRC	Rr, b	Skip if Bit in Register Cleared	if (Rr(b) = 0) PC ← PC + 2 or 3	None	1 / 2 / 3
SBRS	Rr, b	Skip if Bit in Register Set	if (Rr(b) = 1) PC ← PC + 2 or 3	None	1 / 2 / 3
SBIC	A, b	Skip if Bit in I/O Register Cleared	if (I/O(A,b) = 0) PC ← PC + 2 or 3	None	2 / 3 / 4
SBIS	A, b	Skip if Bit in I/O Register Set	If (I/O(A,b) = 1) PC ← PC + 2 or 3	None	2 / 3 / 4
BRBS	s, k	Branch if Status Flag Set	if (SREG(s) = 1) then PC ← PC + k + 1	None	1 / 2
BRBC	s, k	Branch if Status Flag Cleared	if (SREG(s) = 0) then PC ← PC + k + 1	None	1 / 2
BREQ	k	Branch if Equal	if (Z = 1) then PC ← PC + k + 1	None	1 / 2
BRNE	k	Branch if Not Equal	if (Z = 0) then PC ← PC + k + 1	None	1 / 2
BRCS	k	Branch if Carry Set	if (C = 1) then PC ← PC + k + 1	None	1 / 2
BRCC	k	Branch if Carry Cleared	if (C = 0) then PC ← PC + k + 1	None	1 / 2
BRSH	k	Branch if Same or Higher	if (C = 0) then PC ← PC + k + 1	None	1 / 2
BRLO	k	Branch if Lower	if (C = 1) then PC ← PC + k + 1	None	1 / 2
BRMI	k	Branch if Minus	if (N = 1) then PC ← PC + k + 1	None	1 / 2
BRPL	k	Branch if Plus	if (N = 0) then PC ← PC + k + 1	None	1 / 2
BRGE	k	Branch if Greater or Equal, Signed	if (N ⊕ V = 0) then PC ← PC + k + 1	None	1 / 2
BRLT	k	Branch if Less Than, Signed	if (N ⊕ V = 1) then PC ← PC + k + 1	None	1 / 2
BRHS	k	Branch if Half Carry Flag Set	if (H = 1) then PC ← PC + k + 1	None	1 / 2
BRHC	k	Branch if Half Carry Flag Cleared	if (H = 0) then PC ← PC + k + 1	None	1 / 2
BRTS	k	Branch if T Flag Set	if (T = 1) then PC ← PC + k + 1	None	1 / 2
BRTC	k	Branch if T Flag Cleared	if (T = 0) then PC ← PC + k + 1	None	1 / 2
BRVS	k	Branch if Overflow Flag is Set	if (V = 1) then PC ← PC + k + 1	None	1 / 2
BRVC	k	Branch if Overflow Flag is Cleared	if (V = 0) then PC ← PC + k + 1	None	1 / 2
BRIE	k	Branch if Interrupt Enabled	if (I = 1) then PC ← PC + k + 1	None	1 / 2
BRID	k	Branch if Interrupt Disabled	if (I = 0) then PC ← PC + k + 1	None	1 / 2

## Data Transfer Instructions

MOV	Rd, Rr	Copy Register	Rd ← Rr	None	1
MOVW	Rd, Rr	Copy Register Pair	Rd+1:Rd ← Rr+1:Rr	None	1
LDI	Rd, K	Load Immediate	Rd ← K	None	1
LDS	Rd, k	Load Direct from data space	Rd ← (k)	None	2 <sup>(1)(2)</sup>
LD	Rd, X	Load Indirect	Rd ← (X)	None	1 <sup>(1)(2)</sup>
LD	Rd, X+	Load Indirect and Post-Increment	Rd ← (X) X ← X + 1	None	1 <sup>(1)(2)</sup>
LD	Rd, -X	Load Indirect and Pre-Decrement	X ← X - 1 Rd ← (X)	None	2 <sup>(1)(2)</sup>
LD	Rd, Y	Load Indirect	Rd ← (Y)	None	1 <sup>(1)(2)</sup>
LD	Rd, Y+	Load Indirect and Post-Increment	Rd ← (Y) Y ← Y + 1	None	1 <sup>(1)(2)</sup>

## 34. Electrical Characteristics

All typical values are measured at  $T = 25^{\circ}\text{C}$  unless other temperature condition is given. All minimum and maximum values are valid across operating temperature and voltage unless other conditions are given.

### 34.1 Absolute Maximum Ratings\*

Operating Temperature.....	$-55^{\circ}\text{C}$ to $+125^{\circ}\text{C}$
Storage Temperature .....	$-65^{\circ}\text{C}$ to $+150^{\circ}\text{C}$
Voltage on any Pin with respect to Ground..	$-0.5\text{V}$ to $V_{\text{CC}}+0.5\text{V}$
Maximum Operating Voltage .....	$3.6\text{V}$
DC Current per I/O Pin .....	$20.0\text{ mA}$
DC Current $V_{\text{CC}}$ and GND Pins.....	$200.0\text{ mA}$

**\*NOTICE:** Stresses beyond those listed under “Absolute Maximum Ratings” may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or other conditions beyond those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

### 34.2 DC Characteristics

**Table 34-1.** Current Consumption

Symbol	Parameter	Condition			Min.	Typ.	Max.	Units	
I <sub>CC</sub>	Power Supply Current <sup>(1)</sup>	Active	32 kHz, Ext. Clk	V <sub>CC</sub> = 1.8V		30		μA	
				V <sub>CC</sub> = 3.0V		75			
			1 MHz, Ext. Clk	V <sub>CC</sub> = 1.8V		260			
				V <sub>CC</sub> = 3.0V		570			
			2 MHz, Ext. Clk	V <sub>CC</sub> = 1.8V		510	690		
				V <sub>CC</sub> = 3.0V		1.1	1.49	mA	
		32 MHz, Ext. Clk	V <sub>CC</sub> = 3.0V		11.4	13			
			Idle	32 kHz, Ext. Clk	V <sub>CC</sub> = 1.8V		2.8		μA
		V <sub>CC</sub> = 3.0V				4.8			
		1 MHz, Ext. Clk		V <sub>CC</sub> = 1.8V		80			
				V <sub>CC</sub> = 3.0V		150			
		2 MHz, Ext. Clk		V <sub>CC</sub> = 1.8V		160	225		
				V <sub>CC</sub> = 3.0V		295	390		
		Power-down mode			32 MHz, Ext. Clk	V <sub>CC</sub> = 3.0V		4.8	6
	All Functions Disabled, T = 25°C				V <sub>CC</sub> = 3.0V		0.1	3	μA
	All Functions Disabled, T = 85°C				V <sub>CC</sub> = 3.0V		1.5	5	
	ULP, WDT, Sampled BOD, T = 25°C				V <sub>CC</sub> = 1.8V		1.1	6	
					V <sub>CC</sub> = 3.0V		1.1	6	
	ULP, WDT, Sampled BOD, T= 85°C	V <sub>CC</sub> = 3.0V		2.6	10				

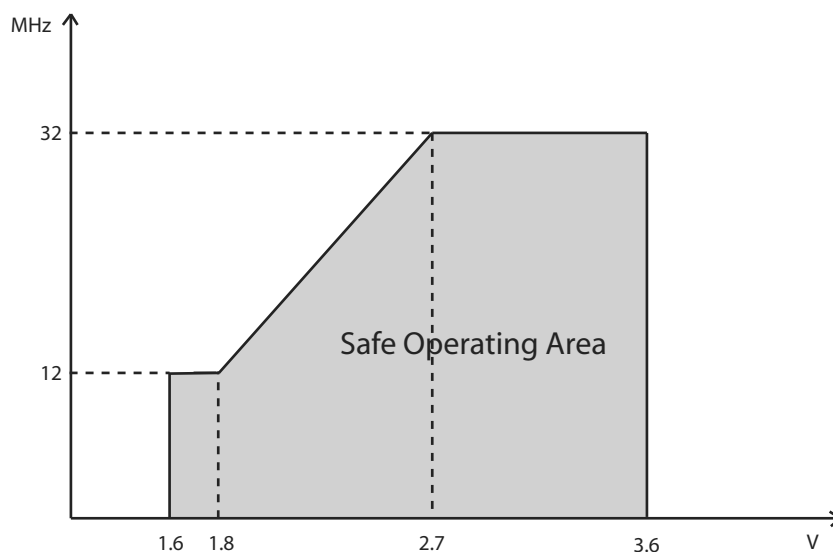
### 34.3 Speed

**Table 34-2.** Operating voltage and frequency

Symbol	Parameter	Condition	Min	Typ	Max	Units
Clk <sub>CPU</sub>	CPU clock frequency	V <sub>CC</sub> = 1.6V	0		12	MHz
		V <sub>CC</sub> = 1.8V	0		12	
		V <sub>CC</sub> = 2.7V	0		32	
		V <sub>CC</sub> = 3.6V	0		32	

The maximum CPU clock frequency of the XMEGA A4 devices is depending on V<sub>CC</sub>. As shown in Figure 34-1 on page 63 the Frequency vs. V<sub>CC</sub> curve is linear between 1.8V < V<sub>CC</sub> < 2.7V.

**Figure 34-1.** Operating Frequency vs.Vcc



## 34.5 ADC Characteristics

**Table 34-5.** ADC Characteristics

Symbol	Parameter	Condition	Min	Typ	Max	Units
RES	Resolution	Programmable: 8/12	8	12	12	Bits
INL	Integral Non-Linearity	500 ksps	-5	$\pm 2$	5	LSB
DNL	Differential Non-Linearity	500 ksps		$< \pm 1$		
	Gain Error			$< \pm 10$		mV
	Offset Error			$< \pm 2$		
ADC <sub>clk</sub>	ADC Clock frequency	Max is 1/4 of Peripheral Clock			2000	kHz
	Conversion rate				2000	ksps
	Conversion time (propagation delay)	(RES+2)/2+GAIN RES = 8 or 12, GAIN = 0 or 1	5	7	8	ADC <sub>clk</sub> cycles
	Sampling Time	1/2 ADC <sub>clk</sub> cycle	0.25			uS
	Conversion range		0		VREF	V
AVCC	Analog Supply Voltage		V <sub>CC</sub> -0.3		V <sub>CC</sub> +0.3	
VREF	Reference voltage		1.0		V <sub>CC</sub> -0.6V	
	Input bandwidth					kHz
INT1V	Internal 1.00V reference <sup>(1)</sup>			1.00		V
INTVCC	Internal V <sub>CC</sub> /1.6			V <sub>CC</sub> /1.6		
SCALEDVCC	Scaled internal V <sub>CC</sub> /10 input			V <sub>CC</sub> /10		
R <sub>AREF</sub>	Reference input resistance			$> 10$		MΩ
	Start-up time			12	24	ADC <sub>clk</sub> cycles
	Internal input sampling speed	Temp. sensor, V <sub>CC</sub> /10, Bandgap			100	ksps

Note: 1. Refer to "Bandgap Characteristics" on page 66 for more parameter details.

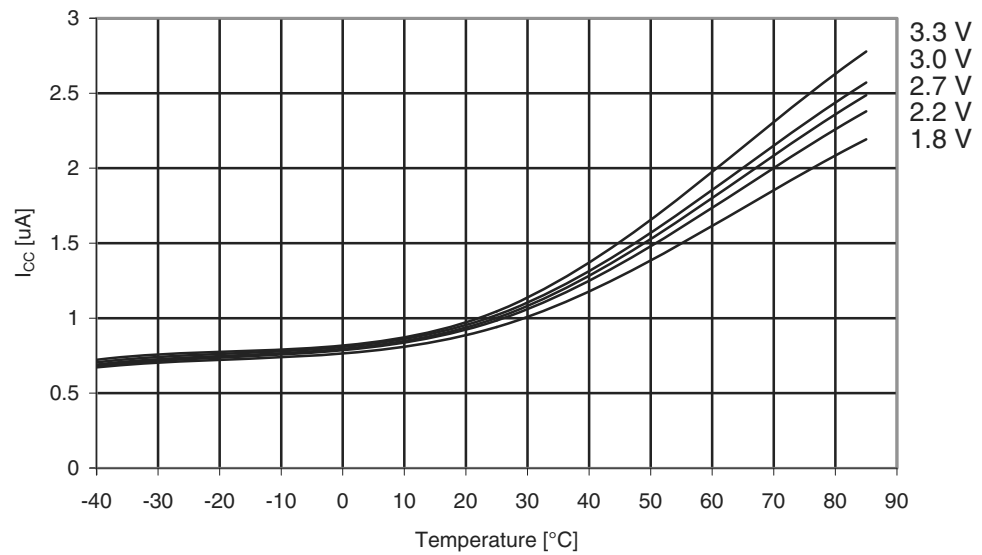
**Table 34-6.** ADC Gain Stage Characteristics

Symbol	Parameter	Condition	Min	Typ	Max	Units
	Gain error	1 to 64 gain		$< \pm 1$		%
	Offset error			$< \pm 1$		mV
Vrms	Noise level at input	64x gain		0.12		
				0.06		
	Clock rate	Same as ADC			1000	kHz

## 35.4 Power-save Supply Current

**Figure 35-17.** Power-save Supply Current vs. Temperature

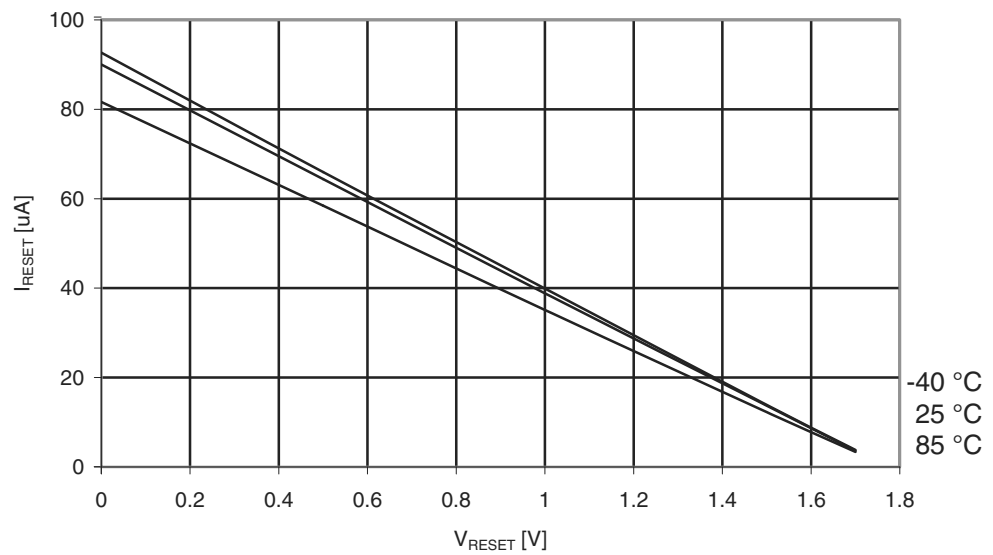
*With WDT, sampled BOD and RTC from ULP enabled.*



## 35.5 Pin Pull-up

**Figure 35-18.** Reset Pull-up Resistor Current vs. Reset Pin Voltage

$V_{CC} = 1.8V$ .

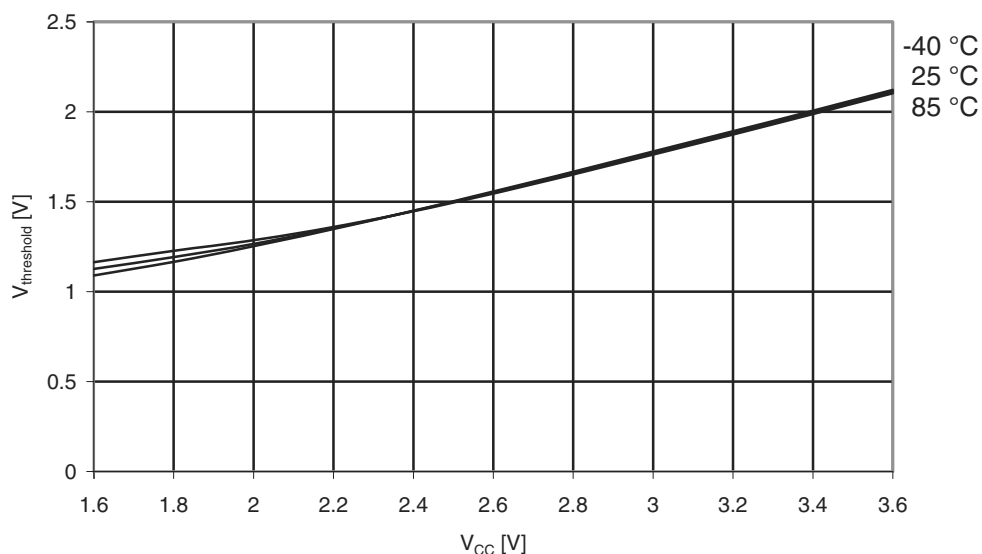




## 35.7 Pin Thresholds and Hysteresis

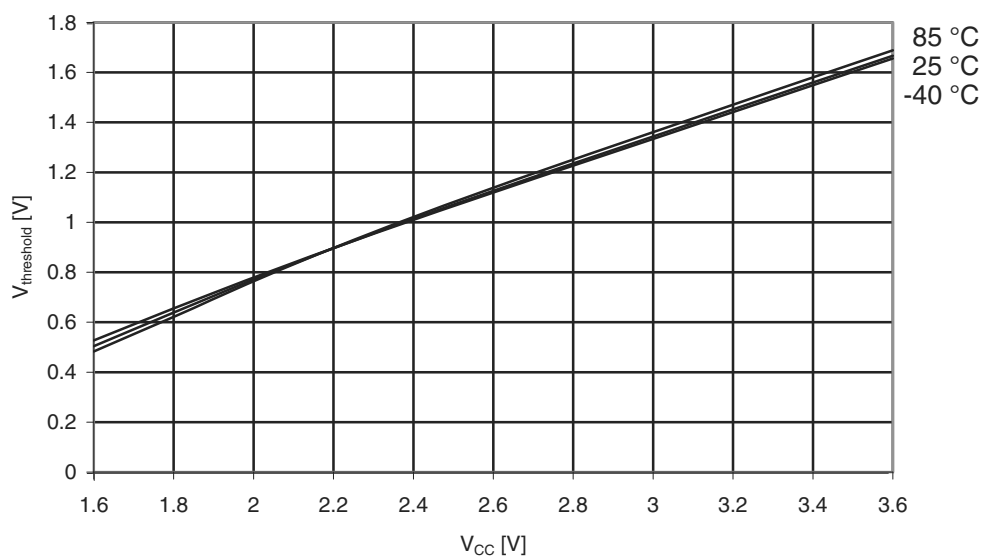
**Figure 35-27.** I/O Pin Input Threshold Voltage vs.  $V_{CC}$

$V_{IH}$  - I/O Pin Read as "1".



**Figure 35-28.** I/O Pin Input Threshold Voltage vs.  $V_{CC}$

$V_{IL}$  - I/O Pin Read as "0".



## 36. Errata

### 36.1 ATxmega16A4, ATxmega32A4

#### 36.1.1 rev. A/B

- Bandgap voltage input for the ACs can not be changed when used for both ACs simultaneously
- VCC voltage scaler for AC is non-linear
- ADC has increased INL error for some operating conditions
- ADC gain stage output range is limited to 2.4 V
- ADC Event on compare match non-functional
- Bandgap measurement with the ADC is non-functional when VCC is below 2.7V
- Accuracy lost on first three samples after switching input to ADC gain stage
- Configuration of PGM and CWCM not as described in XMEGA A Manual
- PWM is not restarted properly after a fault in cycle-by-cycle mode
- BOD: BOD will be enabled at any reset
- Sampled BOD in Active mode will cause noise when bandgap is used as reference
- DAC is nonlinear and inaccurate when reference is above 2.4V or VCC - 0.6V
- DAC has increased INL or noise for some operating conditions
- EEPROM page buffer always written when NVM DATA0 is written
- Pending full asynchronous pin change interrupts will not wake the device
- Pin configuration does not affect Analog Comparator Output
- NMI Flag for Crystal Oscillator Failure automatically cleared
- Flash Power Reduction Mode can not be enabled when entering sleep
- Crystal start-up time required after power-save even if crystal is source for RTC
- RTC Counter value not correctly read after sleep
- Pending asynchronous RTC-interrupts will not wake up device
- TWI Transmit collision flag not cleared on repeated start
- Clearing TWI Stop Interrupt Flag may lock the bus
- TWI START condition at bus timeout will cause transaction to be dropped
- TWI Data Interrupt Flag (DIF) erroneously read as set
- WDR instruction inside closed window will not issue reset

#### 1. Bandgap voltage input for the ACs cannot be changed when used for both ACs simultaneously

If the Bandgap voltage is selected as input for one Analog Comparator (AC) and then selected/deselected as input for another AC, the first comparator will be affected for up to 1  $\mu$ s and could potentially give a wrong comparison result.

##### Problem fix/Workaround

If the Bandgap is required for both ACs simultaneously, configure the input selection for both ACs before enabling any of them.

#### 2. VCC voltage scaler for AC is non-linear

The 6-bit VCC voltage scaler in the Analog Comparators is non-linear.

## Problem fix/Workaround

Keep the amplified voltage output from the ADC gain stage below 2.4 V in order to get a correct result, or keep ADC voltage reference below 2.4 V.

### 5. ADC Event on compare match non-functional

ADC signalling event will be given at every conversion complete even if Interrupt mode (INT-MODE) is set to BELOW or ABOVE.

## Problem fix/Workaround

Enable and use interrupt on compare match when using the compare function.

### 6. Bandgap measurement with the ADC is non-functional when VCC is below 2.7V

The ADC can not be used to do bandgap measurements when VCC is below 2.7V.

## Problem fix/Workaround

None.

### 7. Accuracy lost on first three samples after switching input to ADC gain stage

Due to memory effect in the ADC gain stage, the first three samples after changing input channel must be disregarded to achieve 12-bit accuracy.

## Problem fix/Workaround

Run three ADC conversions and discard these results after changing input channels to ADC gain stage.

### 8. Configuration of PGM and CWCM not as described in XMEGA A Manual

Enabling Common Waveform Channel Mode will enable Pattern generation mode (PGM), but not Common Waveform Channel Mode.

Enabling Pattern Generation Mode (PGM) and not Common Waveform Channel Mode (CWCM) will enable both Pattern Generation Mode and Common Waveform Channel Mode.

## Problem fix/Workaround

**Table 36-1.** Configure PWM and CWCM according to this table:

PGM	CWCM	Description
0	0	PGM and CWCM disabled
0	1	PGM enabled
1	0	PGM and CWCM enabled
1	1	PGM enabled

### 9. PWM is not restarted properly after a fault in cycle-by-cycle mode

When the AWeX fault restore mode is set to cycle-by-cycle, the waveform output will not return to normal operation at first update after fault condition is no longer present.

## Problem fix/Workaround

Do a write to any AWeX I/O register to re-enable the output.

### 10. BOD will be enabled after any reset

If any reset source goes active, the BOD will be enabled and keep the device in reset if the VCC voltage is below the programmed BOD level. During Power-On Reset, reset will not be released until VCC is above the programmed BOD level even if the BOD is disabled.

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## Headquarters

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**Atmel Corporation**  
2325 Orchard Parkway  
San Jose, CA 95131  
USA  
Tel: 1(408) 441-0311  
Fax: 1(408) 487-2600

## International

---

**Atmel Asia**  
Unit 1-5 & 16, 19/F  
BEA Tower, Millennium City 5  
418 Kwun Tong Road  
Kwun Tong, Kowloon  
Hong Kong  
Tel: (852) 2245-6100  
Fax: (852) 2722-1369

**Atmel Europe**  
Le Krebs  
8, Rue Jean-Pierre Timbaud  
BP 309  
78054 Saint-Quentin-en-  
Yvelines Cedex  
France  
Tel: (33) 1-30-60-70-00  
Fax: (33) 1-30-60-71-11

**Atmel Japan**  
9F, Tonetsu Shinkawa Bldg.  
1-24-8 Shinkawa  
Chuo-ku, Tokyo 104-0033  
Japan  
Tel: (81) 3-3523-3551  
Fax: (81) 3-3523-7581

## Product Contact

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**Web Site**  
[www.atmel.com](http://www.atmel.com)

**Technical Support**  
[avr@atmel.com](mailto:avr@atmel.com)

**Sales Contact**  
[www.atmel.com/contacts](http://www.atmel.com/contacts)

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